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S-8264A/B/C Series

BATTERY PROTECTION IC FOR 2-SERIAL TO 4-SERIAL-CELL PACK (SECONDARY PROTECTION)

www.sii-ic.com

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Rev.4.3 00

The S-8264A/B/C Series is used for secondary protection of lithium-ion rechargeable batteries, and incorporates a high-accuracy voltage detection circuit and a delay circuit.

Short-circuiting between cells makes it possible for serial connection of two cells to four cells.

■ Features

- High-accuracy voltage detection circuit for each cell
 - Overcharge detection voltage n (n = 1 to 4)
 - 4.200 V to 4.800 V (in 50 mV steps) Accuracy : ±25 mV (+25°C), Accuracy : ±30 mV (-5°C to +55°C)
 - Overcharge hysteresis voltage n (n = 1 to 4)
 -0.520 ±0.210 V, -0.390 ±0.160 V, -0.260 ±0.110 V, -0.130 ±0.06 V, None
- (2) Delay times for overcharge detection can be set by an internal circuit only (external capacitors are unnecessary)
- (3) Output control function via CTL pin (CTL pin is pulled down internally) (S-8264A Series) Output control function via CTL pin (CTL pin is pulled up internally) (S-8264C Series)
- (4) Output latch function after overcharge detection (S-8264B Series)
- (5) Output form and logic CMOS output active "H"
- (6) High withstand voltage Absolute maximum rating 26 V
- (7) Wide operation voltage range
 (8) Wide operation temperature range
 3.6 V to 24 V
 -40°C to +85°C
- (9) Low current consumption
 - At 3.5 V for each cell
 At 2.3 V for each cell
 5.0 μA max. (+25°C)
 4.0 μA max. (+25°C)
- (10) Lead-free, Sn 100%, halogen-free*1

■ Application

• Lithium-ion rechargeable battery packs (for secondary protection)

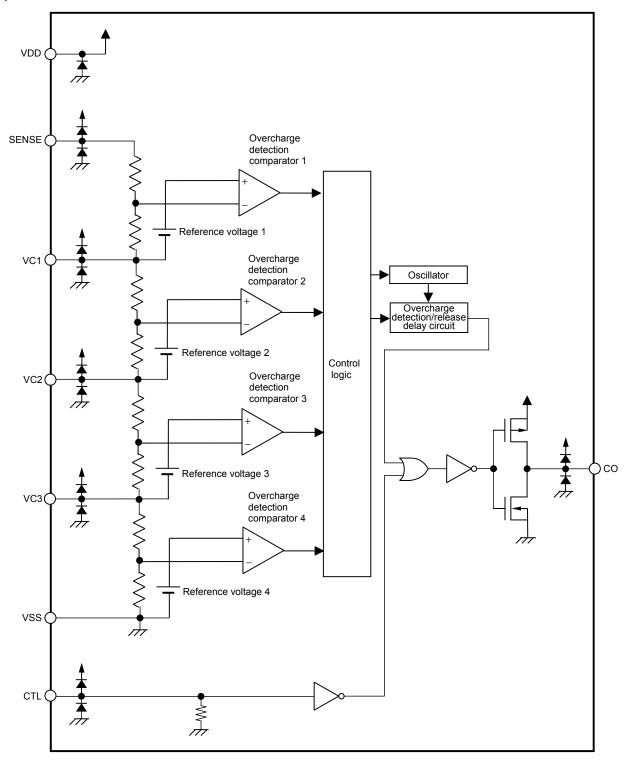
■ Packages

- SNT-8A
- 8-Pin TSSOP

^{*1.} Refer to "■ Product Name Structure" for details.

■ Block Diagrams

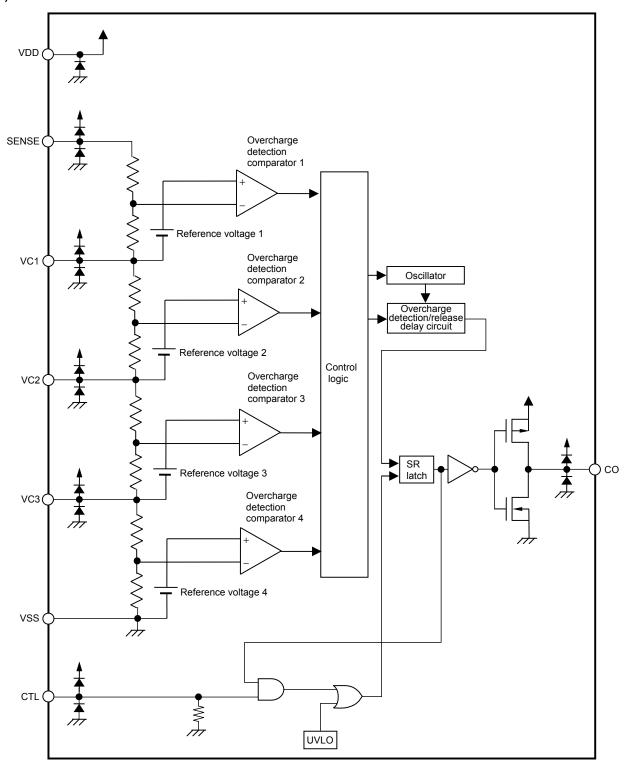
(1) S-8264A Series



Remark The diodes in the figure are parasitic diodes.

Figure 1

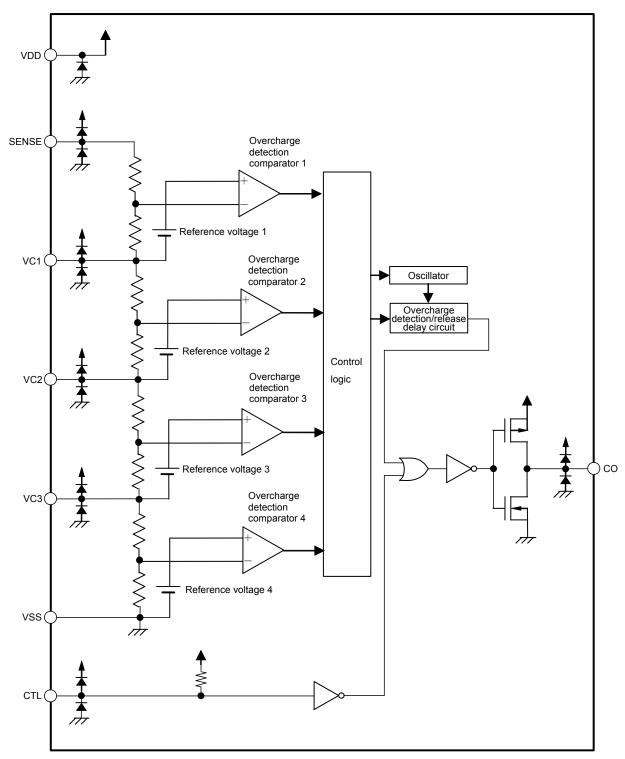
(2) S-8264B Series



Remark The diodes in the figure are parasitic diodes.

Figure 2

(3) S-8264C Series



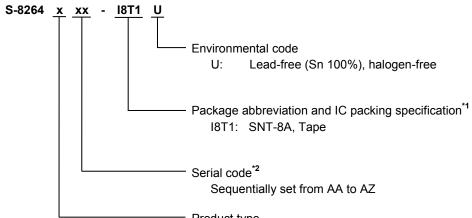
Remark The diodes in the figure are parasitic diodes.

Figure 3

■ Product Name Structure

1. Product Name

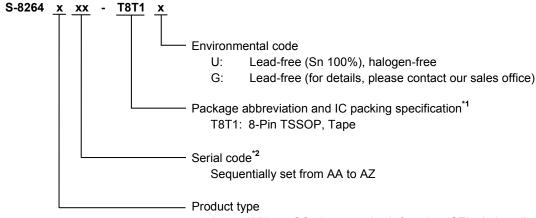
(1) SNT-8A



Product type

- A: Without CO pin output latch function (CTL pin is pulled down internally)
- B: With CO pin output latch function
- C: Without CO pin output latch function (CTL pin is pulled up internally)
- *1. Refer to the tape drawing.
- *2. Refer to "3. Product Name List".

(2) 8-Pin TSSOP



- A: Without CO pin output latch function (CTL pin is pulled down internally)
- B: With CO pin output latch function
- C: Without CO pin output latch function (CTL pin is pulled up internally)
- *1. Refer to the tape drawing.
- *2. Refer to "3. Product Name List".

2. Packages

Package Name		Drawing Code						
		Package	Tape	Reel	Land			
SNT-8A		PH008-A-P-SD	PH008-A-C-SD	PH008-A-R-SD	PH008-A-L-SD			
0 Di- T000D	Environmental code = G	FT008-A-P-SD	FT008-E-C-SD	FT008-E-R-SD				
8-Pin TSSOP	Environmental code = U	FT008-A-P-SD	FT008-E-C-SD	FT008-E-R-S1	_			

3. Product Name List

(1) S-8264A Series

Table 1 SNT-8A

Product Name	Overcharge Detection Voltage [Vcu]	Overcharge Hysteresis Voltage [V _{HC}]	Overcharge Detection Delay Time [tcu]	Output Form
S-8264AAA-I8T1U	4.450 ±0.025 V	-0.390 ±0.160 V	4.0 ±0.8 s	CMOS output active "H"
S-8264AAB-I8T1U	4.350 ±0.025 V	-0.390 ±0.160 V	4.0 ±0.8 s	CMOS output active "H"
S-8264AAC-I8T1U	4.500 ±0.025 V	-0.390 ±0.160 V	4.0 ±0.8 s	CMOS output active "H"
S-8264AAD-I8T1U	4.350 ±0.025 V	-0.390 ±0.160 V	2.0 ±0.4 s	CMOS output active "H"
S-8264AAE-I8T1U	4.300 ±0.025 V	-0.390 ±0.160 V	4.0 ±0.8 s	CMOS output active "H"
S-8264AAF-I8T1U	4.450 ±0.025 V	-0.390 ±0.160 V	2.0 ±0.4 s	CMOS output active "H"
S-8264AAG-I8T1U	4.300 ±0.025 V	-0.390 ±0.160 V	2.0 ±0.4 s	CMOS output active "H"
S-8264AAH-I8T1U	4.400 ±0.025 V	-0.390 ±0.160 V	4.0 ±0.8 s	CMOS output active "H"
S-8264AAI-I8T1U	4.400 ±0.025 V	-0.390 ±0.160 V	2.0 ±0.4 s	CMOS output active "H"
S-8264AAJ-I8T1U	4.450 ±0.025 V	-0.390 ±0.160 V	5.65 ±1.15 s	CMOS output active "H"
S-8264AAK-I8T1U	4.350 ±0.025 V	-0.390 ±0.160 V	5.65 ±1.15 s	CMOS output active "H"
S-8264AAO-I8T1U	4.400 ±0.025 V	-0.390 ±0.160 V	5.65 ±1.15 s	CMOS output active "H"
S-8264AAS-I8T1U	4.500 ±0.025 V	-0.390 ±0.160 V	5.65 ±1.15 s	CMOS output active "H"
S-8264AAT-I8T1U	4.550 ±0.025 V	-0.390 ±0.160 V	5.65 ±1.15 s	CMOS output active "H"

Table 2 8-Pin TSSOP

Product Name	Overcharge Detection Voltage [V _{CU}]	Overcharge Hysteresis Voltage [V _{HC}]	Overcharge Detection Delay Time [tcu]	Output Form	
S-8264AAA-T8T1x	4.450 ±0.025 V	-0.390 ±0.160 V	4.0 ±0.8 s	CMOS output active "H"	
S-8264AAB-T8T1x	4.350 ±0.025 V	-0.390 ±0.160 V	4.0 ±0.8 s	CMOS output active "H"	
S-8264AAK-T8T1U	4.350 ±0.025 V	-0.390 ±0.160 V	5.65 ±1.15 s	CMOS output active "H"	

(2) S-8264B Series

Table 3 SNT-8A

Product Name	Overcharge Detection Voltage [V _{CU}]	Overcharge Hysteresis Voltage [V _{HC}]	Overcharge Detection Delay Time [tcu]	Output Form	
S-8264BAA-I8T1U	4.450 ±0.025 V	-0.390 ±0.160 V	4.0 ±0.8 s	CMOS output active "H"	
S-8264BAB-I8T1U	4.350 ±0.025 V	-0.390 ±0.160 V	4.0 ±0.8 s	CMOS output active "H"	

Table 4 8-Pin TSSOP

Product Name	Overcharge Detection Voltage [V _{CU}]	Overcharge Hysteresis Voltage [V _{HC}]	Overcharge Detection Delay Time [tcu]	Output Form
S-8264BAB-T8T1x	4.350 ±0.025 V	-0.390 ±0.160 V	4.0 ±0.8 s	CMOS output active "H"

(3) S-8264C Series

Table 5 SNT-8A

Product Name	Overcharge Detection Voltage [V _{CU}]	Overcharge Hysteresis Voltage [V _{HC}]	Overcharge Detection Delay Time [tcu]	Output Form	
S-8264CAA-I8T1U	4.450 ±0.025 V	-0.390 ±0.160 V	2.0 ±0.4 s	CMOS output active "H"	
S-8264CAB-I8T1U	4.220 ±0.025 V	-0.260 ±0.110 V	2.0 ±0.4 s	CMOS output active "H"	

Remark 1. Please contact our sales department for the products with detection voltage value other than those specified above.

- 2. x: G or U
- 3. Please select products of environmental code = U for Sn 100%, halogen-free products.

■ Pin Configurations

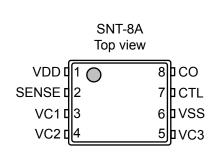


Table 6

Pin No.	Symbol	Description
1	VDD	Positive power input pin
2	SENSE	Positive voltage connection pin of battery 1
3	VC1	Negative voltage connection pin of battery 1 Positive voltage connection pin of battery 2
4	VC2	Negative voltage connection pin of battery 2 Positive voltage connection pin of battery 3
5	VC3	Negative voltage connection pin of battery 3 Positive voltage connection pin of battery 4
6	VSS	Negative power input pin Negative voltage connection pin of battery 4
7	CTL	CO output control pin (S-8264A/C Series) Overcharge detection latch reset pin (S-8264B Series)
8	CO	FET gate connection pin for charge control

Figure 4

Table 7

Description

			1	VDD	Positive power input pin
	8-Pin TSSOF	2	2	SENSE	Positive voltage connection pin of battery 1
Top view			3	VC1	Negative voltage connection pin of battery 1 Positive voltage connection pin of battery 2
9	VDD III 1 O SENSE III 2	8日CO 7日CTL	4	VC2	Negative voltage connection pin of battery 2 Positive voltage connection pin of battery 3
	VC1Ⅲ3 VC2Ⅲ4	6 HVSS 5 VC3		VC3	Negative voltage connection pin of battery 3 Positive voltage connection pin of battery 4
			6	VSS	Negative power input pin Negative voltage connection pin of battery 4
			7	CTL	CO output control pin (S-8264A/C Series) Overcharge detection latch reset pin (S-8264

Pin No.

Symbol

6	VSS	Negative power input pin Negative voltage connection pin of battery 4
7	CTL	
8	СО	FET gate connection pin for charge control

Figure 5

■ Absolute Maximum Ratings

Table 8

(Ta = 25°C unless otherwise specified)

Item		Symbol	Applied Pin	Rating	Unit
Input voltage between VDD and VSS		V_{DS}	VDD	$V_{SS} - 0.3$ to $V_{SS} + 26$	V
Input pin voltage		V _{IN}	SENSE, VC1, VC2, VC3, CTL	$V_{SS} - 0.3$ to $V_{DD} + 0.3$	V
CO output pin voltage		V _{CO}	CO	$V_{SS} - 0.3$ to $V_{DD} + 0.3$	V
Dawar diasination	SNT-8A			450 ^{*1}	mW
Power dissipation	8-Pin TSSOP	P _D		700 ^{*1}	mW
Operation ambient temperature		T _{opr}	_	-40 to +85	°C
Storage temperature		T _{stg}	_	-40 to +125	°C

^{*1.} When mounted on board

[Mounted board]

(1) Board size : $114.3 \text{ mm} \times 76.2 \text{ mm} \times t1.6 \text{ mm}$ (2) Name : JEDEC STANDARD51-7

Caution The absolute maximum ratings are rated values exceeding which the product could suffer physical damage. These values must therefore not be exceeded under any conditions.

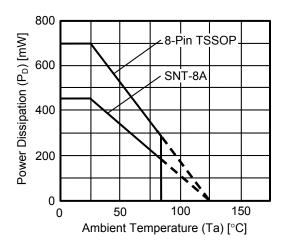


Figure 6 Power Dissipation of Package (When Mounted on Board)

■ Electrical Characteristics

1. Except Detection Delay Time

Table 9

(Ta = 25°C unless otherwise specified)

	(Ta = 25°C unless otherwise specified							
Item	Symbol	Condition	Min.	Тур.	Max.	Unit	Test Condition	Test Circuit
DETECTION VOLTAGE								
Overcharge detection voltage n	V_{CUn}	4.200 V to 4.800 V, adjustable, Ta = 25°C	V _{CUn} -0.025	V_{CUn}	V _{CUn} +0.025	>	1	1
(n = 1, 2, 3, 4)	▼ CUn	4.200 V to 4.800 V, adjustable, Ta = -5° C to $+55^{\circ}$ C ^{*1}	V _{CUn} -0.030	V_{CUn}	V _{CUn} +0.030	V	1	1
Overcharge hysteresis voltage n*2 (n = 1, 2, 3, 4)	V _{HCn}	_	V _{HCn} -0.210	-0.520	V _{HCn} +0.210	٧	1	1
INPUT VOLTAGE								
Operation voltage between VDD and VSS	V_{DSOP}	_	3.6	_	24	V	_	_
CTL input "H" voltage	V_{CTLH}	_	V _{DD} ×0.95	_	_	V	6	2
CTL input "L" voltage	V_{CTLL}	_	_	_	V _{DD} ×0.4	V	6	2
INPUT CURRENT								
Current consumption during operation	I _{OPE}	V1 = V2 = V3 = V4 = 3.5 V	_	2.5	5.0	μΑ	7	4
Current consumption during overdischarge	I _{OPED}	V1 = V2 = V3 = V4 = 2.3 V	_	2.0	4.0	μΑ	7	4
SENSE pin current	I _{SENSE}	V1 = V2 = V3 = V4 = 3.5 V	_	1.5	3.2	μA	8	5
VC1 pin current	I _{VC1}	V1 = V2 = V3 = V4 = 3.5 V	-0.3	0	0.3	μA	8	5
VC2 pin current	I _{VC2}	V1 = V2 = V3 = V4 = 3.5 V	-0.3	0	0.3	μA	8	5
VC3 pin current	I _{VC3}	V1 = V2 = V3 = V4 = 3.5 V	-0.3	0	0.3	μΑ	8	5
CTL pin "H" current	1	A/B Series V1 = V2 = V3 = V4 = 3.5 V, V _{CTL} = V _{DD}	1.1	1.5	1.8	μΑ	8	5
CTE piit in Cutterit	Істін	C Series V1 = V2 = V3 = V4 = 3.5 V V _{CTL} = V _{DD}	_		0.15	μΑ	8	5
CTL pin "L" current	1	A/B Series V1 = V2 = V3 = V4 = 3.5 V, V _{CTL} = 0 V	-0.15	_		μΑ	8	5
	ICTLL	C Series V1 = V2 = V3 = V4 = 3.5 V V _{CTL} = 0 V	-150	-50	-10	μΑ	8	5
OUTPUT CURRENT						·		
CO pin sink current	I _{COL}	$V_{COP} = V_{SS} + 0.5 \text{ V}$	0.4	_		mA	9	6
CO pin source current	Ісон	$V_{COP} = V_{DD} - 0.5 V$	20		_	μΑ	9	6

^{*1.} Since products are not screened at high and low temperature, the specification for this temperature range is guaranteed by design, not tested in production.

^{*2.} $-0.390 \pm 0.160 \text{ V}$, $-0.260 \pm 0.110 \text{ V}$, $-0.130 \pm 0.060 \text{ V}$, or none, except for -0.520 V hysteresis product circuits. The overcharge release voltage is the total of the overcharge detection voltage (V_{CUn}) and the overcharge hysteresis voltage (V_{HCn}).

2. Detection Delay Time

(1) S-8264AAA, S-8264AAB, S-8264AAC, S-8264AAE, S-8264AAH, S-8264BAA, S-8264BAB

Table 10

(Ta = 25°C unless otherwise specified)

Item	Symbol	Condition	Min.	Тур.	Max.	Unit	Test Condition	Test Circuit		
DELAY TIME										
Overcharge detection delay time	tcu	_	3.2	4.0	4.8	S	2	1		
Overcharge timer reset delay time	t _{TR}	_	6	12	20	ms	3	1		
Overcharge release delay time	t _{CL}	_	51	64	77	ms	2	1		
CTL pin response time	t _{CTL}	_	_	_	2.5	ms	4	2		
Transition time to Test mode	t _{TST}	V1 = V2 = V3 = V4 = 3.5 V, $V_{DD} \ge V_{SENSE} + 8.5 V$	_	_	80	ms	5	3		

(2) S-8264AAD, S-8264AAF, S-8264AAG, S-8264AAI, S-8264CAA, S-8264CAB

Table 11

(Ta = 25°C unless otherwise specified)

Item	Symbol	Condition	Min.	Тур.	Max.	Unit	Test Condition	Test Circuit	
DELAY TIME	DELAY TIME								
Overcharge detection delay time	t _{CU}	_	1.6	2.0	2.4	S	2	1	
Overcharge timer reset delay time	t _{TR}	_	6	12	20	ms	3	1	
Overcharge release delay time	t _{CL}	_	1.6	2.0	3.0	ms	2	1	
CTL pin response time	t _{CTL}	_	_		2.5	ms	4	2	
Transition time to Test mode	t _{TST}	V1 = V2 = V3 = V4 = 3.5 V, $V_{DD} \ge V_{SENSE} + 8.5 V$		_	80	ms	5	3	

(3) S-8264AAJ, S-8264AAK, S-8264AAO, S-8264AAS, S-8264AAT

Table 12

(Ta = 25°C unless otherwise specified)

					(14 - 20 O	unicoo c	Juliel Wise S	<i>Jeennea</i>
Item	Symbol	Condition	Min.	Тур.	Max.	Unit	Test Condition	Test Circuit
DELAY TIME								
Overcharge detection delay time	t _{CU}	_	4.5	5.65	6.8	S	2	1
Overcharge timer reset delay time	t _{TR}	_	8	17	28	ms	3	1
Overcharge release delay time	t _{CL}	_	70	88	110	ms	2	1
CTL pin response time	t _{CTL}	_		_	2.5	ms	4	2
Transition time to Test mode	t _{TST}	V1 = V2 = V3 = V4 = 3.5 V, $V_{DD} \ge V_{SENSE} + 8.5 V$		_	80	ms	5	3

■ Test Circuits

(1) Test Condition 1, Test Circuit 1

Set V1, V2, V3, and V4 to 3.5 V. Overcharge detection voltage 1 (V_{CU1}) is the V1 voltage when CO is "H" after the voltage of V1 has been gradually increased. The overcharge hysteresis voltage (V_{HC1}) is the difference between V1 and V_{CU1} when CO is "L" after the voltage of V1 has been gradually decreased.

Overcharge detection voltage V_{CUn} (n = 2 to 4) and overcharge hysteresis V_{HCn} (n = 2 to 4) can be determined in the same way as when n = 1.

(2) Test Condition 2, Test Circuit 1

Set V1, V2, V3, and V4 to 3.5 V and in a moment of time (within 10 μ s) increase V1 up to 5.0 V. The overcharge detection delay time (t_{CU}) is the period from when V1 reached 5.0 V to when CO becomes "H". After that, in a moment of time (within 10 μ s) decrease V1 down to 3.5 V. The overcharge release delay time (t_{CL}) is the period from when V1 has reached 3.5 V to when CO becomes "L".

(3) Test Condition 3, Test Circuit 1

Set V1, V2, V3, and V4 to 3.5 V and in a moment of time (within $10 \,\mu s$) increase V1 up to 5.0 V. This is defined as the first rise. Within $t_{CU} - 20$ ms after the first rise, in a moment of time (within $10 \,\mu s$) decrease V1 down to 3.5 V and then in a moment of time (within $10 \,\mu s$) restore up to 5.0 V. This is defined as the second rise. When the period from when V1 was fallen to the second rise is short, CO becomes "H" after t_{CU} has elapsed since the first rise. If the period from when V1 falls to the second rise is gradually made longer, CO becomes "H" when t_{CU} has elapsed since the second rise. The overcharge timer reset delay time (t_{TR}) is the period from V1 fall till the second rise at that time.

(4) Test Condition 4, Test Circuit 2

In the S-8264A/C Series, set V1, V2, V3, and V4 to 3.5 V and V5 to 14 V. The CTL pin response time (t_{CTL}) is the period from when V5 reaches 0 V after V5 is in a moment of time (within 10 μ s) decreased down to 0 V to when CO becomes "H".

In the S-8264B Series, set V1, V2, V3, and V4 to 3.5 V and V5 to 14 V after an overvoltage is detected and CO becomes "H". In a moment of time (within 10 μ s) raise V5 from 0 V to 14 V. The CTL pin response time (t_{CTL}) is the period from when V5 becomes 14 V to when CO becomes "L".

(5) Test Condition 5, Test Circuit 3

After setting V1, V2, V3, and V4 to 3.5 V and V5 to 0 V, in a moment of time (within $10 \,\mu s$) increase V5 up to 8.5 V and decrease V5 again down to 0 V. When the period from when V5 was raised to when it has fallen is short, if an overcharge detection operation is performed subsequently, the overcharge detection time is t_{CU} . However, when the period from when V5 is raised to when it is fallen is gradually made longer, the overcharge detection time during the subsequent overcharge detection operation is shorter than t_{CU} . The transition time to test mode (t_{TST}) is the period from when V5 was raised to when it has fallen at that time.

(6) Test Condition 6, Test Circuit 2

Set V1, V2, V3, and V4 to 3.5 V and V5 to 0 V. The CTL input "H" voltage (V_{CTLH}) is the maximum voltage of V5 when CO is "L" after V5 has been gradually increased. Next, set V5 to 14 V. The CTL input "L" voltage (V_{CTLL}) is the minimum voltage of V5 when CO is "H" after V5 has been gradually decreased.

(7) Test Condition 7, Test Circuit 4

The current consumption during operation (I_{OPE}) is the total of the currents that flow in the VDD pin and SENSE pin when V1, V2, V3, and V4 are set to 3.5 V.

The current consumption during overdischarge (I_{OPED}) is the total of the currents that flow in the VDD pin and SENSE pin when V1, V2, V3, and V4 are set to 2.3 V.

(8) Test Condition 8, Test Circuit 5

The SENSE pin current (I_{SENSE}) is I1, the VC1 pin current (I_{VC1}) is I2, the VC2 pin current (I_{VC2}) is I3, the VC3 pin current (I_{VC3}) is I4, and the CTL pin "H" current (I_{CTLH}) is I5 when V1, V2, V3, and V4 are set to 3.5 V, and V5 to 14 V. The CTL pin "L" current (I_{CTLL}) is I5 when V1, V2, V3, and V4 are set to 3.5 V and V5 to 0 V.

(9) Test Condition 9, Test Circuit 6

Set SW1 to OFF and SW2 to ON. The CO pin sink current (I_{COL}) is I2 when V1, V2, V3, and V4 are set to 3.5 V and V6 to 0.5 V.

Set SW1 and SW2 to OFF. Set V1 to V5, set V2, V3, and V4 to 3.0 V, and set V5 to 0.5 V. After t_{CU} has elapsed, set SW1 to ON and SW2 to OFF. I1 is the CO pin source current (I_{COH}).

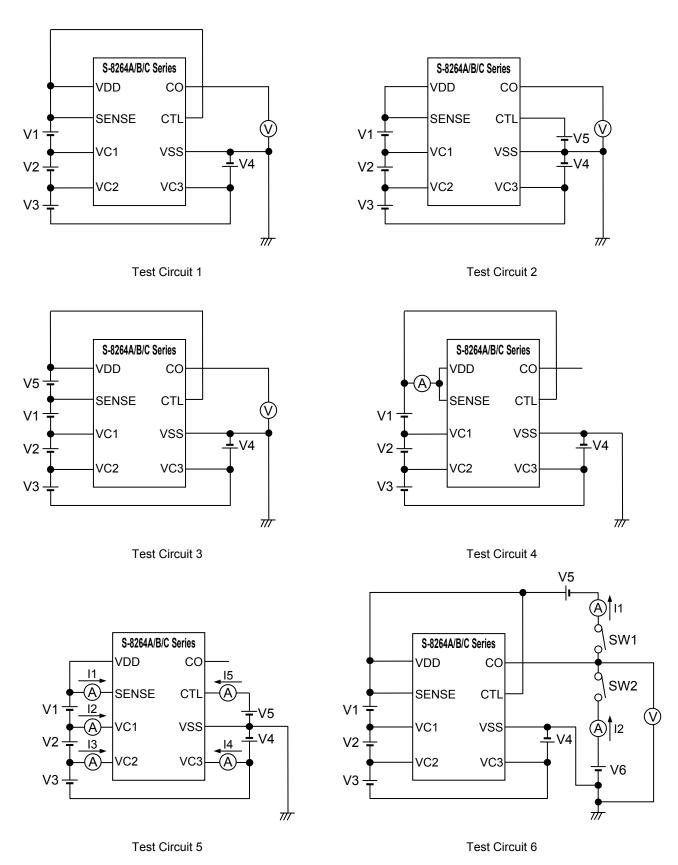


Figure 7

■ Operation

Remark Refer to "■ Battery Protection IC Connection Example".

1. Overcharge Detection

When the voltage of one of the batteries exceeds the overcharge detection voltage (V_{CU}) during charging under normal conditions and the state is retained for the overcharge detection delay time (t_{CU}) or longer, CO becomes "H". This state is called overcharge. Connecting FET to the CO pin provides charge control and a second protection.

In the S-8264A/C Series, if the voltage of each of the batteries is lower than V_{CU} + the overcharge hysteresis voltage (V_{HC}) and the state is retained for the overcharge release delay time (t_{CL}) or longer, CO becomes "L".

In the S-8264B Series, if the voltage of each of the batteries is lower than $V_{CU} + V_{HC}$ and the state is retained for t_{CL} or longer, the overcharge state is released; however, CO stays at "H". When the CTL pin is switched from "L" to "H", CO becomes "L".

2. Overcharge Timer Reset Operation

When an overcharge release noise that forces the voltage of one of the batteries temporarily below V_{CU} is input during t_{CU} from when V_{CU} is exceeded to when charging is stopped, t_{CU} is continuously counted if the time the overcharge release noise persists is shorter than the overcharge timer reset delay time (t_{TR}). Under the same conditions, if the time the overcharge release noise persists is t_{TR} or longer, counting of t_{CU} is reset once. After that, when V_{CU} has been exceeded, counting t_{CU} resumes.

3. CTL Pin

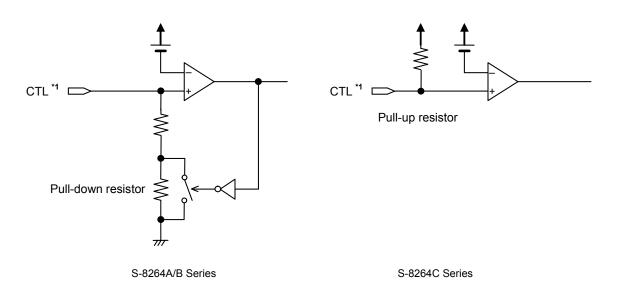
The S-8264A/B/C Series has a control pin. The CTL pin is used to control the output voltage of the CO pin. In the S-8264A/C Series, the CTL pin takes precedence over the overcharge detection circuit.

In the S-8264B Series, when the CTL pin is switched from "L" to "H", a reset signal is output to the overcharge detection latch and CO becomes "L".

CTL Pin	CO Pin					
	S-8264A Series	S-8264B Series	S-8264C Series			
"H"	Normal state*1	Without latch	Normal state*1			
Open	"H"	Normal state*1	Normal state*1			
"L"	"H"	Normal state*1	"H"			
"L" → "H"	-	Latch reset*2	_			
"H" → "L"	_	_	_			

Table 13 Control via CTL Pin

- *1. The state is controlled by the overcharge detection circuit.
- *2. Latch reset becomes effective when the voltage of each of the batteries is lower than the overcharge detection voltage (V_{CU}) + the overcharge hysteresis voltage (V_{HC}) and the overcharge release delay time (t_{CL}) has elapsed.



*1. The reverse voltage "H" to "L" or "L" to "H" of CTL pin is VDD pin voltage – 2.8 V (Typ.), does not have the hysteresis.

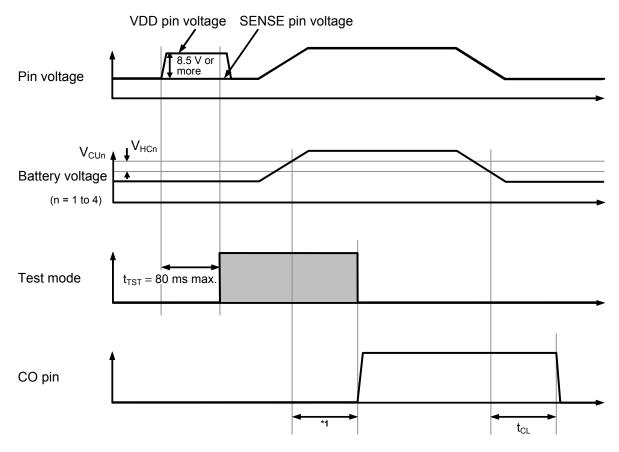
Figure 8 Internal Equivalent Circuit of CTL Pin

- Caution 1. In the S-8264A/B Series, since the CTL pin implements high resistance of 8 M Ω to 12 M Ω for pull down, be careful of external noise application. If an external noise is applied, CO may become "H". Perform thorough evaluation using the actual application.
 - 2. In the S-8264B Series, when the CTL pin is open or "L", CO latches "H". When the VDD pin voltage is decreased to the UVLO voltage of 2 V (Typ.) or lower, the latch is reset.

4. Test Mode

In the S-8264A/B/C Series, the overcharge detection delay time (t_{CU}) can be shortened by entering the test mode. The test mode can be set by retaining the VDD pin voltage 8.5 V or more higher than the SENSE pin voltage for at least 80 ms (V1 = V2 = V3 = V4 = 3.5 V, Ta = 25°C). The status is retained by the internal latch and the test mode is retained even if the VDD pin voltage is decreased to the same voltage as that of the SENSE pin.

When CO becomes "H" when the delay time has elapsed after overcharge detection, the latch for retaining the test mode is reset and the S-8264A/B Series exits from the test mode.



*1. In the product t_{CU} = 4 s Typ. during normal mode, t_{CU} = 64 ms Typ. In the product t_{CU} = 2 s Typ. during normal mode, t_{CU} = 32 ms Typ. In the product t_{CU} = 5.65 s Typ. during normal mode, t_{CU} = 88 ms Typ.

Figure 9

- Caution 1. When the VDD pin voltage is decreased to lower than the UVLO voltage of 2 V (Typ.), the S-8264A/B/C Series returns to the normal mode.
 - 2. Set the test mode when no batteries are overcharged.
 - 3. The overcharge release delay time (t_{CL}) is not shortened in the test mode.
 - 4. The overcharge timer reset delay time (t_{TR}) is not shortened in the test mode.

■ Timing Charts

1. Overcharge Detection Operation

(1) S-8264A/C Series

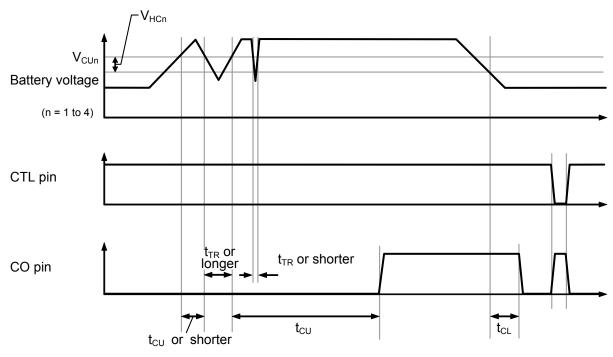


Figure 10

(2) S-8264B Series

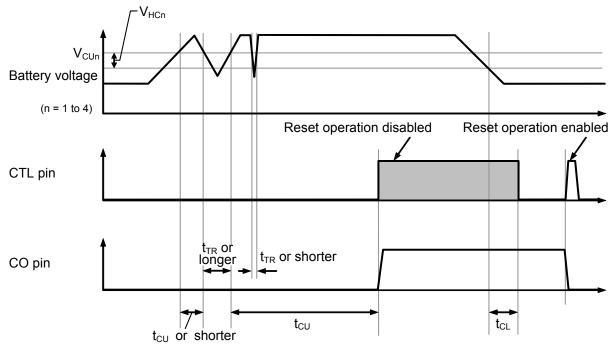


Figure 11

2. Overcharge Timer Reset Operation

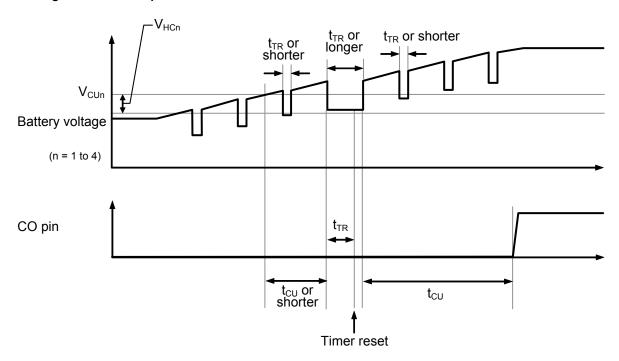


Figure 12

■ Battery Protection IC Connection Example

(1) 4-serial cell

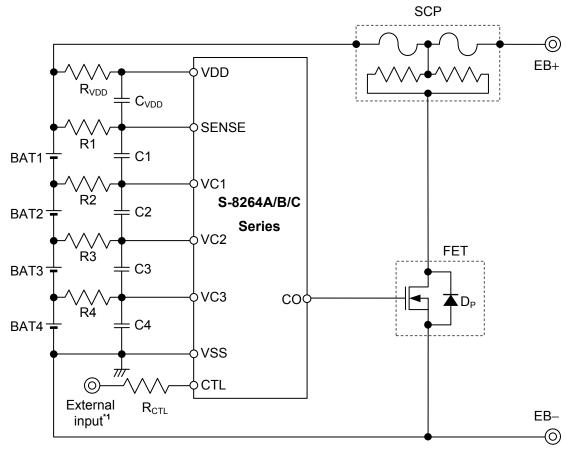


Figure 13

*1. Refer to Table 13 for setting on external input.

Table 14 Constants for External Components

No.	Part	Min.	Тур.	Max.	Unit
1	R1 to R4	0.1	1	10	kΩ
2	C1 to C4, C _{VDD}	0.01	0.1	1	μF
3	R_{VDD}	50	100	500	Ω
4	R _{CTL}	0	100	500	Ω

Caution

- 1. The above constants are subject to change without prior notice.
- 2. It has not been confirmed whether the operation is normal or not in circuits other than the above example of connection. In addition, the example of connection shown above and the constant will not guarantee successful operation. Perform thorough evaluation using the actual application to set the constant.
- 3. Set the same constants to R1 to R4 and to C1 to C4 and C_{VDD} .
- 4. Set R_{VDD}, C1 to C4, and C_{VDD} so that the condition (R_{VDD}) × (C1 to C4, C_{VDD}) \geq 5 × 10⁻⁶ is satisfied.
- 5. Set R1 to R4, C1 to C4, and C_{VDD} so that the condition (R1 to R4) \times (C1 to C4, C_{VDD}) \geq 1 \times 10⁻⁴ is satisfied.
- 6. Since "H" may be output at CO transiently when the battery is being connected, connect the positive terminal of BAT1 last in order to prevent the three terminal protection fuse from cutoff.

(2) 3-serial cell

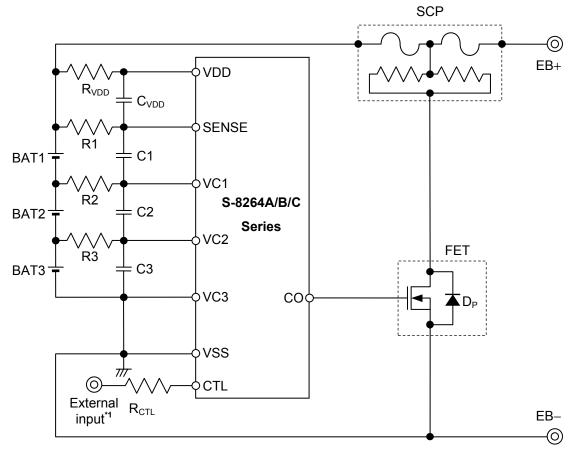


Figure 14

*1. Refer to Table 13 for setting on external input.

Table 15 Constants for External Components

No.	Part	Min.	Тур.	Max.	Unit
1	R1 to R3	0.1	1	10	kΩ
2	C1 to C3, C _{VDD}	0.01	0.1	1	μF
3	R_{VDD}	50	100	500	Ω
4	R _{CTL}	0	100	500	Ω

Caution 1. The above constants are subject to change without prior notice.

- It has not been confirmed whether the operation is normal or not in circuits other than the above example of connection. In addition, the example of connection shown above and the constant will not guarantee successful operation. Perform thorough evaluation using the actual application to set the constant.
- 3. Set the same constants to R1 to R3 and to C1 to C3 and C_{VDD} .
- 4. Set R_{VDD} , C1 to C3, and C_{VDD} so that the condition $(R_{VDD}) \times (C1$ to C3, $C_{VDD}) \ge 5 \times 10^{-6}$ is satisfied.
- 5. Set R1 to R3, C1 to C3, and C_{VDD} so that the condition (R1 to R3) \times (C1 to C3, C_{VDD}) \geq 1 \times 10⁻⁴ is satisfied.
- 6. Since "H" may be output at CO transiently when the battery is being connected, connect the positive terminal of BAT1 last in order to prevent the three terminal protection fuse from cutoff.

(3) 2-serial cell

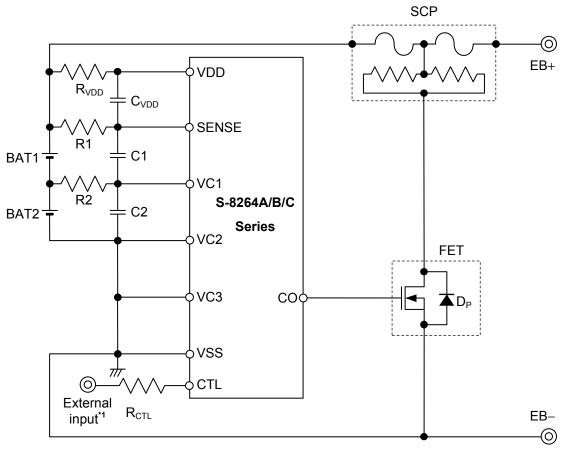


Figure 15

*1. Refer to Table 13 for setting on external input.

Table 16 Constants for External Components

No.	Part	Min.	Тур.	Max.	Unit
1	R1 and R2	0.1	1	10	kΩ
2	C1 and C2, C _{VDD}	0.01	0.1	1	μF
3	R _{VDD}	50	100	500	Ω
4	R _{CTL}	0	100	500	Ω

Caution 1. The above constants are subject to change without prior notice.

- 2. It has not been confirmed whether the operation is normal or not in circuits other than the above example of connection. In addition, the example of connection shown above and the constant will not guarantee successful operation. Perform thorough evaluation using the actual application to set the constant.
- 3. Set the same constants to R1 to R3 and to C1 to C3 and C_{VDD} .
- 4. Set R_{VDD} , C1 to C3, and C_{VDD} so that the condition $(R_{VDD}) \times (C1$ to C3, $C_{VDD}) \ge 5 \times 10^{-6}$ is satisfied.
- 5. Set R1 to R3, C1 to C3, and C_{VDD} so that the condition (R1 to R3) \times (C1 to C3, C_{VDD}) \geq 1 \times 10⁻⁴ is satisfied.
- 6. Since "H" may be output at CO transiently when the battery is being connected, connect the positive terminal of BAT1 last in order to prevent the three terminal protection fuse from cutoff.

■ Precautions

- Do not connect batteries charged with V_{CU} + V_{HC} or higher. If the connected batteries include a battery charged with V_{CU} + V_{HC} or higher, "H" may be output at CO after all pins are connected.
- In some application circuits, even if an overcharged battery is not included, the order of connecting batteries may be restricted to prevent transient output of CO detection pulses when the batteries are connected. Perform thorough evaluation with the actual application circuit.
- In the S-8264B Series, "H" may be output at CO after all the pins are connected. In this case, set the CTL pin from "L" to "H".
- Before the battery connection, short-circuit the battery side pins R_{VDD} and R1, shown in the figure in "■ Battery Protection IC Connection Example".
- The application conditions for the input voltage, output voltage, and load current should not exceed the package power dissipation.
- Do not apply to this IC an electrostatic discharge that exceeds the performance ratings of the built-in electrostatic protection circuit.
- SII Semiconductor Corporation claims no responsibility for any disputes arising out of or in connection with any infringement of patents owned by a third party by products including this IC.

■ Example of Application Circuit

1. Overheat Protection via PTC (S-8264A Series)

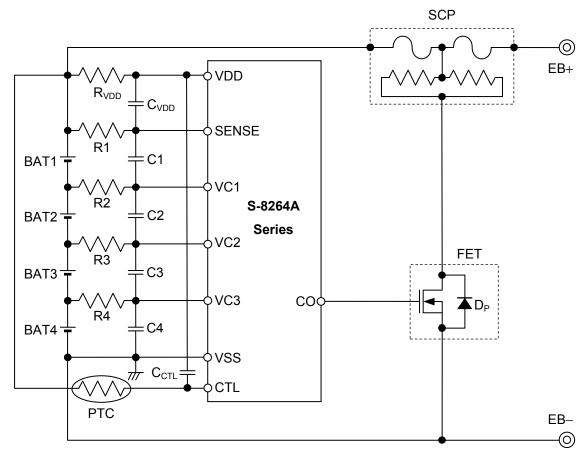


Figure 16

- Cautions 1. The above connection example will not guarantee successful operation. Perform thorough evaluation using the actual application.
 - 2. A pull-down resistor is included in the CTL pin. To perform overheat protection via the PTC in the S-8264A Series, connect the PTC before connecting batteries.
 - 3. When the power fluctuation is large, connect the power supply of the PTC to the VDD pin of the S-8264A Series.
 - 4. Since "H" may be output at CO transiently when the battery is being connected, connect the positive terminal of BAT1 last in order to prevent the three terminal protection fuse from cutoff.

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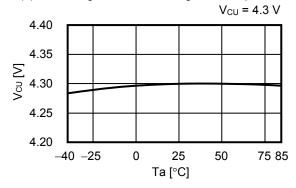
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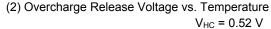
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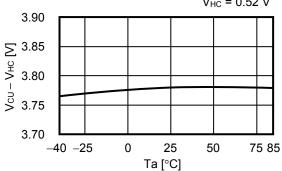
■ Characteristics (Typical Data)

1. Detection Voltage vs. Temperature

(1) Overcharge Detection Voltage vs. Temperature

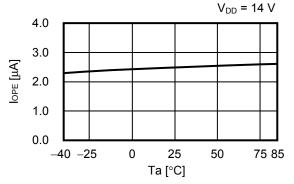




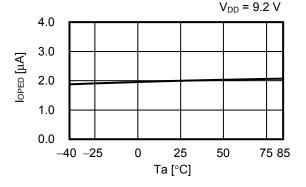


2. Current Consumption vs. Temperature

(1) Current Consumption during Normal Operation vs. Temperature

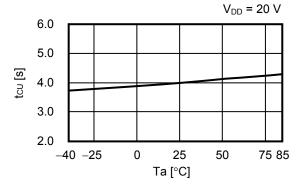


(2) Current Consumption during Overdischarge vs. Temperature



3. Delay Time vs. Temperature

(1) Overcharge Detection Delay Time vs. Temperature



(2) Overcharge Release Delay Time vs. Temperature

